





N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)}	I _D T _A = +25°C
20V	0.55Ω @ $V_{GS} = 4.5V$	630mA
20 V	$0.9\Omega @ V_{GS} = 1.8V$	410mA

Description

This new generation MOSFET has been designed to minimize the onstate resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- **Power Management Functions**

Features and Benefits

- Low On-Resistance: $R_{DS(ON)} = 550_{(max)} m\Omega$ @ $V_{GS} = 4.5V$
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected up to 2KV
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

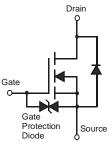
Mechanical Data

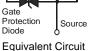
- Case: SOT23
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin annealed over Alloy 42 leadframe. Solderable per MIL-STD-202, Method 208 @3
- Terminal Connections: See Diagram
- Weight: 0.008 grams (approximate)

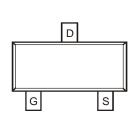




SOT23







Top View

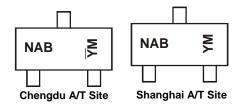
Ordering Information (Note 4)

Part Number	Case	Packaging
DMN2004K-7	SOT23	3000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + CI) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



NAB = Product Type Marking Code YM = Date Code Marking for SAT (Shanghai Assembly/ Test site) YM = Date Code Marking for CAT (Chengdu Assembly/ Test site) Y or \overline{Y} = Year (ex: A = 2013)

M = Month (ex: 9 = September)

Date Code Key

Year	2008		2009	2010		2011	2012		2013	2014		2015
Code	V		W	Х		Υ	Z		Α	В		С
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D

July 2013



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characte	eristic		Symbol	Value	Units
Drain-Source Voltage			V _{DSS}	20	V
Gate-Source Voltage			V _{GSS}	±8	V
Drain Current (Note 5) V _{GS} = 4.5V	Steady State	$T_A = +25^{\circ}C$ $T_A = +85^{\circ}C$	I _D	630 450	mA
Drain Current (Note 5) V _{GS} = 1.8V	Steady State	$T_A = +25^{\circ}C$ $T_A = +85^{\circ}C$	I _D	410 300	mA
Pulsed Drain Current (Note 6)			I _{DM}	1.5	A

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units
Total Power Dissipation (Note 5)	P_{D}	350	mW
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	357	°C/W
Operating and Storage Temperature Range	$T_{J_i}T_{STG}$	-65 to +150	°C

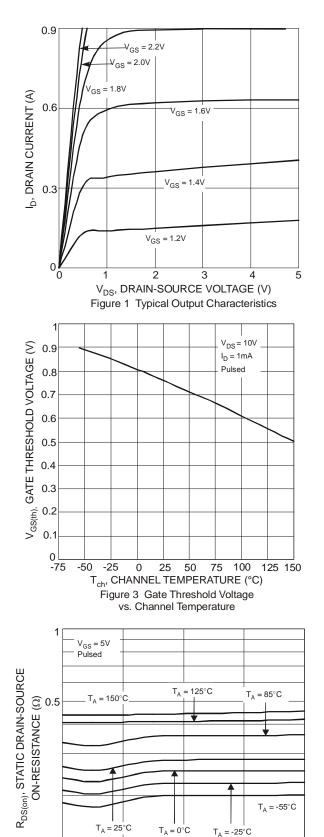
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV _{DSS}	20	_	_	V	$V_{GS} = 0V, I_D = 10\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μA	V _{DS} = 16V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	_	_	±1	μA	$V_{GS} = \pm 4.5V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(th)}	0.5	_	1.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
			0.4	0.55		$V_{GS} = 4.5V, I_D = 540mA$
Static Drain-Source On-Resistance	R _{DS(ON)}	_	0.5	0.70	Ω	$V_{GS} = 2.5V, I_D = 500mA$
			0.7	0.9		$V_{GS} = 1.8V, I_D = 350mA$
Forward Transfer Admittance	Y _{fs}	200	_	_	ms	$V_{DS} = 10V, I_D = 0.2A$
Source Current	IS	_	_	0.5	Α	_
Diode Forward Voltage (Note 7)	V _{SD}	0.6	_	1	V	$V_{GS} = 0V, I_{S} = 500mA$
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{iss}	_	_	150	pF	
Output Capacitance	Coss		_	25	pF	$V_{DS} = 16V, V_{GS} = 0V$ f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	_	_	20	pF	
Gate Resistance	R_g	_	292	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge	Q_g	_	0.9	_		
Gate-Source Charge	Q_{gs}	_	0.2	_	nC	$V_{DS} = 15V$, $V_{GS} = 4.5V$, $I_{D} = 0.5A$
Gate-Drain Charge	Q_{gd}	_	0.2	_		
Turn-On Delay Time	t _{D(on)}	_	5.7	_		
Turn-On Rise Time	t _r	_	8.4	_		$V_{GS} = 8V, V_{DS} = 15V,$
Turn-Off Delay Time	t _{D(off)}	_	59.4	_	ns	$R_G = 6\Omega$, $R_L = 30\Omega$
Turn-Off Fall Time	t _f	_	37.6	_		
Body Diode Reverse Recovery Time	t _{rr}	_	5.5	_	ns	I _S = 0.5A, dI/dt = -100A/μs
Body Diode Reverse Recovery Charge	Q _{rr}		0.85	—	nC	$I_S = 0.5A$, $dI/dt = -100A/\mu s$

Notes:

- 5. Device mounted on FR-4 PCB, with minimum recommended pad layout, single sided.
 6. Pulse width ≤10µS, Duty Cycle ≤1%.
 7. Short duration pulse test used to minimize self-heating effect.





1,000 $V_{DS} = 10V$ 900 Pulsed 800 I_D, DRAIN CURRENT (mA) 700 600 500 400 300 = 150°C 200 = 85°C $T_A = 25^{\circ}C$ 100 $T_{\Delta} = -55^{\circ}C$ 0.4 1.2 8.0 V_{GS}, GATE-SOURCE VOLTAGE (V)

Figure 2 Reverse Drain Current vs. Source-Drain Voltage

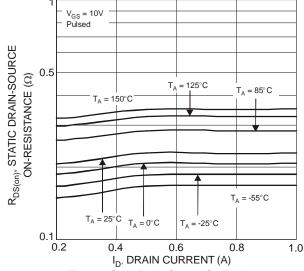


Figure 4 Static Drain-Source On-Resistance vs. Drain Current

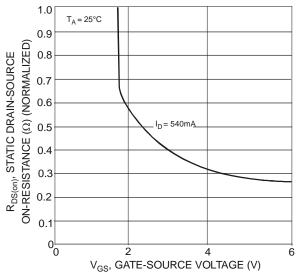


Figure 6 Static Drain-Source, On-Resistance vs. Gate-Source Voltage

0.4

0.6

I_D, DRAIN CURRENT (A)

Figure 5 Static Drain-Source On-Resistance

vs. Drain Current

8.0

0.1

0.2

1.0



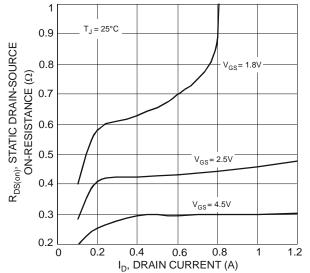
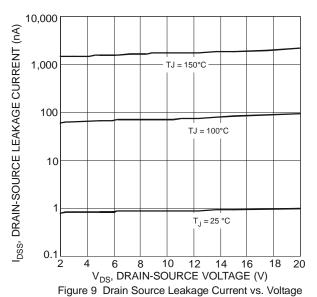


Figure 7 On-Resistance vs. Drain Current and Gate Voltage



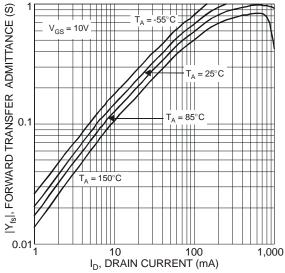


Figure 11 Forward Transfer Admittance vs. Drain Current

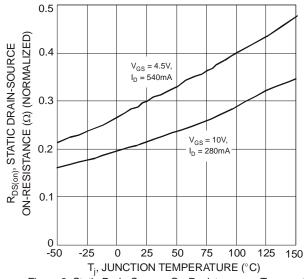


Figure 8 Static Drain-Source, On-Resistance vs. Temperature

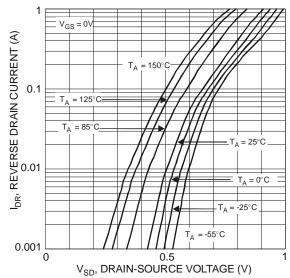
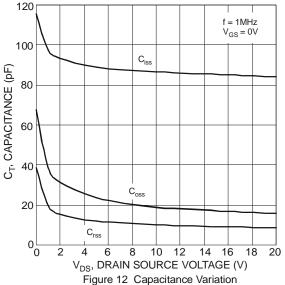
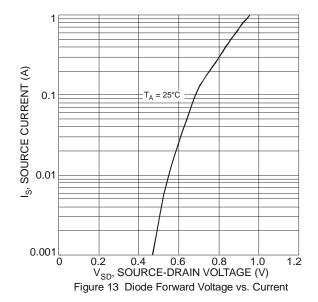
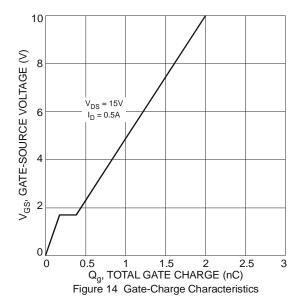


Figure 10 Reverse Drain Current vs. Source-Drain Voltage



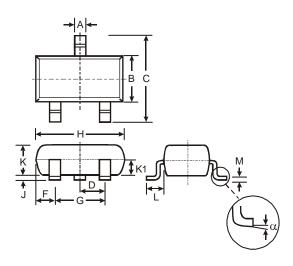






Package Outline Dimensions

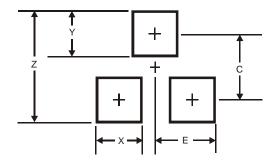
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SOT23							
Dim	Min	Max	Тур				
Α	0.37	0.51	0.40				
В	1.20	1.40	1.30				
С	2.30	2.50	2.40				
D	0.89	1.03	0.915				
F	0.45	0.60	0.535				
G	1.78	2.05	1.83				
Η	2.80	3.00	2.90				
7	0.013	0.10	0.05				
K	0.903	1.10	1.00				
K1	-	1	0.400				
L	0.45	0.61	0.55				
М	0.085	0.18	0.11				
α	0°	8°	-				
All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for latest version.



Dimensions	Value (in mm)			
Z	2.9			
Х	0.8			
Υ	0.9			
С	2.0			
E	1.35			



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